Silicon detectors for photo-detection

Samo Korpar

University of Maribor and J. Stefan Institute, Ljubljana

September 26 – 30, 2010

3rd MC-PAD Network Training Event, Ljubljana

Outline

- Introduction
- Detection of light with solid state sensors
	- photo diode
	- avalanche photo diode (APD)
	- hybrid photo detectors (HPD, HAPD)
	- APD operated in Geiger mode
	- Silicon photomultiplier
- Applications (SiPM):
	- aerogel RICH development for Belle II
	- astrophysics Cherenkov telescopes
	- CALICE and T2K large system experience

Detection of photons (light)

Photomultiplier:

- conversion: photon produces photo-electron
- amplification: photo-electron is accelerated toward the first dynode where it starts the amplification process, secondary electrons continue the amplification process throughout the dynode structure
- signal: at the end the charge is collected by the anode
- bulky, sensitive to magnetic field, high voltage, lower QE

Silicon detectors for photo-detection (slide 3)

Application examples

Calorimeters:

- Belle calorimeter with PIN photodiodes
- ~ 50000 photons/MeV
- CMS calorimeter with APDs
- ~ 100 photons/MeV

Cherenkov light detection:

• Belle-II aerogel RICH prototype module with SiPMs – detection of single photons

Fiber trackers, medical imaging (PET), TOF ...

Silicon detectors for photo-detection (slide 4)

Si optical properties

- large variation of absorption length $(10nm-10\mu m) \rightarrow$ limits QE for short and long wavelengths
- \bullet high refractive index \rightarrow high reflectivity \rightarrow anti-reflecting coating is used

September 26 – 30, 2010

PAD Network Training Event, Ljubljana

3

Photo diode (p-n, p-i-n)

- photons absorbed in the depleted region generate photo-current
- no amplification can detect light pulses with large number of photons $(>$ ~10⁴)
- Si band gap energy 1.12eV (wavelength 1100nm)
- p-i-n \rightarrow lower V_{bias} and C

3

September 26 – 30, 2010 PAD Network Training Event, Ljubljana **Silicon detectors for photo-detection (slide 6)**

 \cdot depleted region \sim 100 µm thick

Avalanche photodiode

Photodiode with high field amplification region:

- both carriers can participate in amplification
- modest amplification up to 1000 limited by start of pair production by holes \rightarrow leads to avalanche breakdown.

electron

Multiplication process in APD

• not capable of single photon detection

n

Distance

absorption

VLPC (Visual Light Photon Counter) is impurity band conduction silicon diode capable of detecting single photons. Band gap energy \neg 50meV \rightarrow operation at cryogenic temperature (6.5K). Used for D0 fiber tracker.

Electric field

Hybrid photo detectors

- Single photon detection can be achieved by using PD or APD in vacuum device (replacing dinode structure):
- photon interacts in photocathode and produces photoelectron
- high electric field accelerates photoelectron
- on impact electron-hole pairs are generated (bombardment gain)
- \bullet in APD signal is further amplified \rightarrow lower HV and higher gain
- photon counting

Silicon detectors for photo-detection (slide 9)

LHCb RICH HPD:

- \bullet electron optics \rightarrow 5x demagnification
- sensitive to magnetic field
- \bullet HV ~20kV, gain ~5k
- detector in operation
- CERN+DEP-Photonis

September 26 – 30, 2010 PAD Network Training Event, Ljubljana **Silicon detectors for photo-detection (slide 10)**

Belle II aerogel RICH HAPD

- proximity focusing configuration
- operation in magnetic field
- \cdot HV ~8kV, gain ~100k
- Belle + Hamamatsu

Silicon detectors for photo-detection (slide 11)

APDs operated in Geiger mode

Another option is to operate the APD in Geiger mode.

Bias voltage is increased above the breakdown voltage and avalanche must be stopped by:

- active bias control or
- quenching resistor

Large are APD operating in Geiger mode would be most of the time in the recovery state due to the large number of dark counts.

Solution: localization of quenching, division of large area APD in an array of smaller ones → SiPM (1990's: Golovin, Sadygov)

SiPM – Structure

SiPM is an array of Geiger mode APDs (micro cells) each consisting of: • p-n structure with high field region • quenching resistor connected to common electrode by metal strips

Hamamatsu MPPC with 50um cells

Manny producers: Photonique/CPTA, MEPhI/PULSAR, Hamamatsu, MPI, FBKirst, STMicroelectronics, SensL, Philips (dSiPM), Zecotec ... using different names: SiPM, MRS APD, MAPD, SSPM, MPPC, PPD ...

SiPM – Signal

- SiPM signal sequence:
- \bullet charged to V_{bias}
- carrier enters breakdown region and initiates the avalanche
- \bullet micro cell is discharged to $V_{\text{breakdown}}$ and avalanche process stops \bullet micro cell is recharged to V_{bias} – during this time a new avalanche
- process in the same micro cell will result in a reduced signal

Simplified explanation of output signal $(C_p$ ~20fF, R_s~1kΩ, R_o~100kΩ). Parasitic capacitances $\mathsf{C}_\text{\tiny Q}$ and $\mathsf{C}_\text{\tiny P}$ also influence the output signal.

SiPM - Gain

Gain is determined by micro cell capacitance $(-10 - 100$ fF) and overvoltage – the difference between bias and breakdown voltage (typically few volts).

$$
G = C_{m.c.} \times (V_{bias} - V_{breakdown})/e_0
$$

- large gains, typically $10⁵ 10⁷$ • short signals (~10 ns) produce several mV on 50 Ohm
- total signal is the sum of signals from individual micro cells
- afterpulses and optical crosstalk also contribute to total charge produced by single photon

Photon counting(?)

3

Silicon detectors for photo-detection (slide 15)

SiPM – Gain vs. temperature

Breakdown voltage changes with temperature \rightarrow gain variation. Not critical for single photon detection.

September 26 – 30, 2010 PAD Network Training Event, Ljubljana **Silicon detectors for photo-detection (slide 16)**

SiPM-Dark noise

Any free carrier entering breakdown region produces the same signal as single photon. The rate of breakdowns initiated by thermally generated carriers is in the range of 100 kHz to several MHz per mm² at room temperature. Thermal generation can be reduced by:

- cooling \rightarrow factor 2 every 8°C
- smaller electric field (also reduces gain and PDE)

Signals are at the single micro cell level and can be effectively suppressed by threshold level at the signal of few micro cells (depends on optical cross talk level).

Silicon detectors for photo-detection (slide 17)

SiPM-Afterpulses

Deep traps are loaded during the avalanche processes and carriers that are subsequently released trigger afterpulses:

- afterpulses can occur several hundred ns after the primary pulse
- probability for afterpulses increases with overvoltage – higher gain

3

September 26 – 30, 2010 PAD Network Training Event, Ljubljana **Silicon detectors for photo-detection (slide 18)**

SiPM-Optical cross-talk

Optical cross-talk is generated when photon produced in the avalanche process escapes to the neighboring cell and initiates Geiger discharge \rightarrow large excess noise factor.

It is the main cause of the larger number of fired micro cells in dark pulses than expected from accidental coincidences (Poisson probability).

Increases with overvoltage – higher gain.

Y. Kudenko (INR Moscow)@PD07

Silicon detectors for photo-detection (slide 19)

SiPM - Optical cross-talk suppresion

- Optical crosstalk can be suppressed by shielding one micro cell from the other:
- tranches are introduced between the cells
- typically lower photon detection efficiency – more dead space

September 26 – 30, 2010 PAD Network Training Event, Ljubljana **Silicon detectors for photo-detection (slide 20)**

External secondary photon cross talk

Will SiPMs "communicate"? Scan one SiPM in front of a second one and observe coincidence rate

- \cdot single sensor dark rate \sim 200 kHz
- \bullet coincidence background rate \sim 2.4 kHz
- coincidence rate increase when face to face \sim 1 kHz
- 1 mm active area 1 mm away
	- \rightarrow ~ 15% of 2 π solid angle
- full (2π) solid angle: 1kHz/(2x200kHz)/15% ~ 2%
- \rightarrow OK, increase of background at % level

Silicon detectors for photo-detection (slide 21)

External secondary photon cross talk

Photons escaping SiPM can be reflected back when SiPM is coupled to crystal. Wavelength distribution of light escaping from SiPM

Effect can be suppressed by use of color filter:

- 5x5 mm2 SiPM with OC suppr.
- operated at gain 107
- \cdot LYSO 4x4x20 mm3
- BGC20 color filter

R. Mirzoyan (MPI Munich) @ PD09

September 26 – 30, 2010 PAD Network Training Event, Ljubljana **Silicon detectors for photo-detection (slide 22)**

SiPM-Signal saturation NIM A540 (2005) 368

- Output of SiPM is saturated if number of photons in the pulse is comparable to number of micro cells:
- photons hitting the same micro cell count as one for signal charge
- if photons are simultaneous (Cherenkov light) signal limit is number of pixels (disregarding after-pulse contribution)
- saturation can be approximated by

PDE⋅*N ph.*

$$
N_{sig} = N_{all} \cdot (1 - e^{-\frac{PDE \cdot N_{ph}}{N_{all}}})
$$

• pulses from scintillators with decay times longer than pixel recovery time can produce signals significantly exceeding number of micro cells

3

September 26 – 30, 2010 PAD Network Training Event, Ljubljana **Silicon detectors for photo-detection (slide 23)**

SiPM-Timing

Fast rise time of the signal and high gain result in an excelent timing properties of SiPMs. Single photon timing resolution is on the order of 100ps. Applications to TOF, PET-TOF etc. are being investegated.

September 26 – 30, 2010 PAD Network Training Event, Ljubljana **Silicon detectors for photo-detection (slide 24)**

SiPM – Photon detection efficiency

 $PDE = Q.E. \times \epsilon_{geom} \times \epsilon_{Geiger}$ Photon detection efficiency (PDE) depends on three factors:

- quantum efficiency (mainly absorption of photons in active volume)
- geometrical efficiency ratio of active to total area
- probability for a carrier to initiate avalanche
	- depends on electric field
	- higher for electrons than holes
- \rightarrow increases with overvoltage

Silicon detectors for photo-detection (slide 25)

SiPM – PDE measurements

Standard measurement of QE by measuring photo current overestimates PDE by up to 30% due to the underestimation of the gain measured without including afterpulses. More accurate results are obtained by pulse counting method.

Current measurement is renormalized to points measured by pulse counting.

September 26 – 30, 2010 PAD Network Training Event, Ljubljana **Silicon detectors for photo-detection (slide 26)**

SiPM – p on n vs. n on p

n on p - green/red light sensitive:

• electrons drift to Geiger region from substrate and holes from surface side \cdot higher dark count rate – most of the thermally generated carriers arriving to Geiger region are electrons

p on n - green/blue light sensitive:

• electrons drift to Geiger region from surface and holes from substrate side \cdot lover dark count rate – most of the thermally generated carriers arriving to Geiger region are electrons

SiPM - Irradiation by γ **rays from ⁶⁰Co**

- moderate leakage current is observed and corresponding increase of dark counts
- functionality still OK after 240 Gy

3

PAD Network Training Event, Ljubljana

 \bullet damage is produced mainly in SiO₂ layer – along the metal traces

SiPM – p,n irradiation

- non ionizing energy loss coses lattice defects where carriers are thermally generated \rightarrow dark count rate increases as expected
- increase of afterpulses
- detection of many photon pulses still OK

 1.5

 $10⁵$

 $10⁴$

 $10³$

NoiseRate [kHz]

September 26 – 30, 2010 PAD Network Training Event, Ljubljana **Silicon detectors for photo-detection (slide 29)**

SiPM – p,n irradiation

 \rightarrow Very hard to use present SiPMs as single photon detectors after fluence of 10¹¹ n/cm² 1MeV neutrons

SiPM – Summary of characteristics

In many ways SiPM behaves like an ordinary PMT and is a very promising photon detector for Cherenkov applications. Advantages:

- high PDE
- low bias voltage (less than 100V)
- high gain single photon detection
- excellent timing
- operation in magnetic field
- (potentially low cost?)
- Disadvantages (low light intensity):
- high dark count rate
- \bullet sensitive to radiation damage (n,p)

Belle II aerogel RICH development

- SiPM based photon detector was considered for aerogel RICH.
- 8x8 array of MPPCs + light guides was produced
- module was tested in the test beam with 1cm thick aerogel radiator and performed well

September 26 – 30, 2010 PAD Network Training Event, Ljubljana **Silicon detectors for photo-detection (slide 32)**

FACT project

- SiPM based module for camera for a Cherenkov telescope (DWARF: Dedicated multi Wavelength AGN Research Facility)
- 144 SiPMs + Winston cones
- 36 electronic channels

T. Krähenbühel (ETH Zurich) @ PD09

September 26 – 30, 2010 PAD Network Training Event, Ljubljana **Silicon detectors for photo-detection (slide 33)**

CALICE – first large system experience

• only 8 bad channels in 3 years of testing – mostly mechanical problems

CALICE: Calorimeter for the Linear Collider Experiment

sensor)

+ response uniformity

- Several producers/sensor types
- Which sensor ist best for the application?
- Characterisation is needed

Silicon detectors for photo-detection (slide 34)

Samo Korpar

University of Maribor and Jožef Stefan Institute

BACKUP SLIDES

Conferences:

- PD09, Matsumoto (http://www-conf.kek.jp/PD09/)
- TIPP09, Tsukuba (http://tipp09.kek.jp/)
- PD07, Kobe ([http://www-conf.kek.jp/PD07/\)](http://www-conf.kek.jp/PD07/)
- RICH2010, Cassis (http://rich2010.in2p3.fr/)
- RICH2007, Trieste (http://rich2007.ts.infn.it/index.php)

Overview papers:

- D. Renker and E. Lorenz (JINST-P04004)
- D. Renker (NIM A598 (2009) 207)
- J. Haba (NIM A595 (2008) 154)

and other conferences and related papers …

SiPM – different types

back illuminated: bulk integrated resistor:

MAPD with deep microwells (MAPD-3):

Silicon detectors for photo-detection (slide 37)

SiPM – PDE vs. incidence angle

When light concentrators are used photon incidence angles on SiPM are increased. PDE shows no variation up to measured angle of 60°.

The epoxy resin was removed to get rid of refraction.

 \Rightarrow No angle dependence was found within the measurement error (approx. 1%) up to 60° .

T. Krähenbühel (ETH Zurich) @ PD09

dSiPM-Digital SiPM (Philips)

Signal from each pixel is is digitized and the information is processed on chip:

- time of first fired pixel is measured
- number of fired pixels is counted
- active control is used to recharge fired cells
- 4 x 2047 micro cells
- 50% fill factor including electronics
- integrated TDC with 8ps resolution

September 26 – 30, 2010 PAD Network Training Event, Ljubljana **Silicon detectors for photo-detection (slide 39)**

Samo Korpar University of Maribor and Jožef Stefan Institute

T. Frach (Philips) @ IEEE2009

dSiPM – TOF-PET application

- \cdot 3X3x5 mm³ LYSO in coincidence, 22 Na source
- Time resolution in coincidence: 153ps FWHM
- Energy resolution (excluding escape peak): 10.7%
- Excess voltage 3.3V, 98.5% active cells
- Room temperature (31°C board temperature, not stabilized)

T. Frach (Philips) @ IEEE2009

Light concentration

Can be used if light comes within the limited solid angle

• Winston cones produce large angular spread at the exit surface – photons can miss the active area

• hemispherical light concentrators give better results with large spacing between concentrator and SiPM

September 26 – 30, 2010 PAD Network Training Event, Ljubljana **Silicon detectors for photo-detection (slide 41)**

MAGIC project

First detection of air-shower Cherenkov light presented at RICH 2007. On average larger signal in SiPM modules than in PMT modules.

E. Lorenz (MPI,ETH) @ RICH2007

September 26 – 30, 2010 PAD Network Training Event, Ljubljana **Silicon detectors for photo-detection (slide 42)**

T2K – first experiment with SiPMs

• same type of SiPM used in many detectors in total more than 60000

\cdot all have been tested \rightarrow very low number of bad samples

Using the same MPPC

- $1.3x1.3$ mm² specifically designed for T2K
	- Well suited for 1 mm diameter fiber
- 667 pixels
	- $-26x2650 \mu m$ pixels minus 9 in the corner for lead
- Dark noise < 1.2 MHz at nominal voltage (7.5 $10⁵$ gain at 25C)

Conservatively removed **F. Retier (T2K)**

PAD Network Training Event, Ljubljana

Silicon detectors for photo-detection (slide 43)

